

**Notice of References Cited**

Application/Control No.

09/989,519

Applicant(s)/Patent Under  
Reexamination  
RAITHEL ET AL. *DS*

Examiner

Uyen T. Le

Art Unit

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2002/0103727	08-2002	Tait et al.	705/28
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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**FOREIGN PATENT DOCUMENTS**

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